

Notice of References Cited	Application/Control No. 09/914,182	Applicant(s)/Patent Under Reexamination JETTEN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 99/23117	05-1999		Viikari et al.	--/--
	O					
	P					
	Q					
	R					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,632,802	01-1972	BeMiller et al.	-- / --
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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